

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/026,826	CHOI ET AL.	
Examiner	Art Unit	
Shick C. Hom	2666	

SEARCHED				
Class	Subclass	Date	Examiner	
	updated search	7/29/2005	SH	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Search	7/29/2005	SH	
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